

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket No. 15670-0029US1	Application No. 10/558,842
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)		Applicant <b>Chung-Kuan Cheng, et al.</b>	
		Filing Date <b>January 18, 2007</b>	Group Art Unit
(37 CFR §1.98(b))			

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	1	2009/0132975	5/21/2009	Cheng et al.			
	2	7,555,416	6/30/2009	Cheng et al.			

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
	3	WO 2006/078302	7/27/2006	WIPO			
	4	WO 2006/132639	12/14/2006	WIPO			

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	5	U.S. EXAMINER Kandasamy Thangavelu, Non-Final Office Action dated September 9, 2008 for U.S. Patent Application Serial No. 11/777,211, filed on July 12, 2007 (20 pages)
	6	U.S. EXAMINER Victor J. TAYLOR, International Search Report and Written Opinion dated December 30, 2005 for PCT/US05/20242, international filing date June 7, 2005, (12 pages)
	7	U.S. EXAMINER David C. PAYNE, International Search Report and Written Opinion dated September 26, 2006 for PCT/US05/23131, international filing date June 29, 2005 (11 pages)
	8	U.S. EXAMINER Matthew SMITH, International Search Report and Written Opinion dated December 17, 2004 for PCT/US04/17237, international filing date June 1, 2004 (12 pages)
	9	GERMAN EXAMINER Klaus LERBINGER, Supplementary European Search Report dated July 12, 2006 for EP 04 753 957, (2 pages)
	10	GERMAN EXAMINER Klaus LERBINGER, European Examination Report dated November 2, 2006 for EP 04 753 957, (6 pages)
	11	Zhu, Z. et al., "An unconditional stable general operator splitting method for transistor level transient analysis," Asia and South Pacific Conference on Design Automation, Jan. 24-27, 2006, 6 pages

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	